TOSHIBA Photocoupler GaAlAs Ired & Photo IC

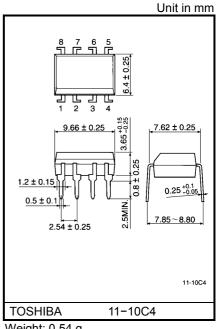
TLP2630

Degital Logic Isolation Tele-Communication **Analog Data Equipment Control** Microprocessor System Interface

The TOSHIBA TLP2630 dual photocoupler consists of a pair of GaAlAs light emitting diode and integrated high gain, high speed photodetector.

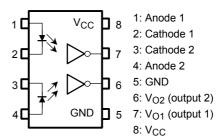
The output of the detector circuit is an open collector, schottky clamped transistor. This unit is 8-lead DIP.

- Input current threshold: $I_F = 5mA(max.)$
- LSTTL/TTL compatible: 5V supply
- Switching speed: 10MBd(typ.)
- Guaranteed performance over temperature: 0~70°C
- Isolation voltage: 2500V_{rms}(min.)
- UL recognized: UL1577, file no. E67349



Weight: 0.54 g

Pin Configuration (top view)

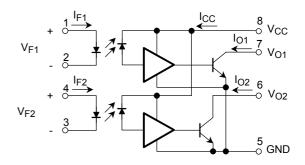


Truth Table (positive logic)

Input	Output
Н	L
L	Н

A 0.01 to 0.1µF bypass capacitor must connected between pins 8 and 5 (see Note 1).

Schematic



Maximum Ratings (no derating required up to 70°C)

Characteristic		Symbol	Rating	Unit
	Forward current(each channel)	l _F	20	mA
LED	Pulse forward current (each channel)*	I _{FP}	30	mA
	Reverse voltage(each channel)	V_{R}	5	V
	Output current(each channel)	ΙO	16	mA
'n	Output voltage(each channel)	Vo	-0.5~7	V
Detector	Supply voltage (1 minute maximum)	V _{CC}	7	V
	Output collector power dissipation(each channel)	Po	40	mW
Oper	Operating temperature range		-55~125	°C
Stora	Storage temperature range		-40~85	°C
Lead	soldering temperature (10 s) (Note 1)	T _{sol}	260	°C
Isolat	tion voltage (AC, 1 min., R.H.≤ 60%, Note 3)	BVS	2500	Vrms

^{*} t ≤ 1 msec duration.

Recommended Operating Conditions

Characteristic	Symbol	Min.	Тур.	Max.	Unit
Input current, low level, each channel	I _{FL}	0	_	250	μΑ
Input current, high level, each channel	I _{FH}	6.3*	_	15	mA
Supply voltage, output	V _{CC}	4.5	5	5.5	V
Fan out(TTL load, each channel)	N	_	_	8	
Operating temperature	T _{opr}	0		70	°C

^{* 6.3}mA is a guard banded value which allows for at least 20% CTR degradation. Initial input current threshold value is 5.0mA or less.

Electrical Characteristics (Ta = $0\sim70^{\circ}$ C, unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.*	Max.	Unit	
Input forward voltage (each channel)	V _F	I _F = 10mA, Ta = 25°C		_	1.65	1.75	V
Input diode temperature coefficient(each channel)	ΔV _F / ΔTa	I _F = 10mA		_	-2.0	_	mV / °C
Input reverse breakdown voltage(each channel)	BV _R	I _R = 10μA, Ta = 25°C		5	_	_	V
Input capacitance (each channel)	C _T	V _F = 0, f = 1MHz		_	45	_	pF
High level output current (each channel)	ІОН	$V_{CC} = 5.5V, V_{O} = 5.5V$ $I_{F} = 250\mu A$		_	1	250	μΑ
Low level output voltage (each channel)	V _{OL}	V_{CC} = 5.5V, I_F = 5mA I_{OL} (sinking) = 13mA		_	0.4	0.6	٧
High level supply current (both channels)	Іссн	V _{CC} = 5.5V, I _F = 0		_	14	30	mA
Low level supply current (both channels)	I _{CCL}	V _{CC} = 5.5V, I _F = 10mA		_	24	36	mA
Isolation voltage	R _S	V _S = 500V, R.H.≤ 60%	(Note 3)		10 ¹⁴	_	Ω
Capacitance(input-output)	C _S	f = 1MHz	(Note 3)	—	0.6		pF
Input-input leakage current	I _{I-I}	R.H.≤ 60%, t = 5s V _{I-I} = 500V	(Note 6)	_	0.005	_	μΑ
Resistance(input-input)	R_{I-I}	V _{I-I} = 500V	(Note 6)	_	10 ¹¹	_	Ω
Capacitance(input-input)	C _{I-I}	f = 1MHz	(Note 6)	_	0.25	_	pF

 $^{^{\}star}$ $\,$ All typical values are at VCC = 5V, Ta = 25°C.

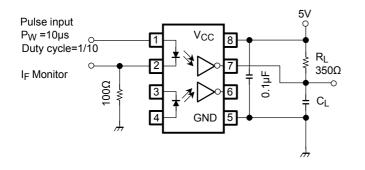
Switching Characteristics (Ta =25°C, V_{CC}=5V)

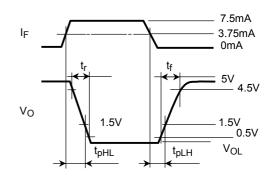
Characteristic	Symbol	Test Cir– cuit	Test Condition	Min.	Тур.	Max.	Unit
Propagation delay time to low output level	t _{pHL}	1	I_F = 0 \rightarrow 7.5mA, R_L = 350Ω C_L = 15pF (each channel)	_	60	75	ns
Propagation delay time to high output level	t _{pLH}	1	I_F = 7.5mA \rightarrow 0, R _L = 350Ω C _L = 15pF (each channel)	_	60	75	ns
Output rise a time,output fall time(10~90%)	t _r ,t _f	1	$I_F = 0 \overrightarrow{\leftarrow} 7.5 \text{mA}, R_L = 350\Omega$ $C_L = 15 \text{pF} \text{ (each channel)}$	_	30	_	ns
Common mode transient immunity at high output level	CM _H	2	$\begin{split} I_F &= 0, \ R_L = 350\Omega \\ V_{CM} &= 200V \\ V_{O}(\text{min.}) &= 2V \\ & (\text{each channel, Note 4}) \end{split}$	ı	200	l	V / µs
Common mode transient immunity at low output level	CML	2	$\begin{split} I_{\text{F}} = 7.5 \text{mA}, R_{\text{L}} = 350 \Omega \\ V_{\text{CM}} = 200 \text{V} \\ V_{\text{O}}(\text{max.}) = 0.8 \text{V} \\ \text{(each channel, Note 5)} \end{split}$	l	-500		V / µs

- (Note 1) 2mm below seating plane.
- (Note 2) The V_{CC} supply voltage to each TLP2630 isolator must be bypassed by a $0.01\mu F$ capacitor or larger. This can be either a ceramic or solid tantalum capacitor with good high frequency characteristic and should be connected as close as possible to the package V_{CC} and GND pins each device.
- (Note 3) Device considered a two–terminal device: Pins 1, 2, 3 and 4 shorted together, and pins 5, 6, 7 and 8 shorted together.
- (Note 4) CM_H·the maximum tolerable rate of rise of the common mode voltage to ensure the output will remain in the high state(i.e., V_{OUT} > 2.0V)
- (Note 5) CM_L·the maximum tolerable rate of fall of the common mode voltage to ensure the output will remain in the low output state(i.e., V_{OUT} > 0.8V)

 Measured in volts per microsecond(V / µs).
- (Note 6) Measured between pins 1 and 2 shorted together, and pins 3 and 4 shorted together.

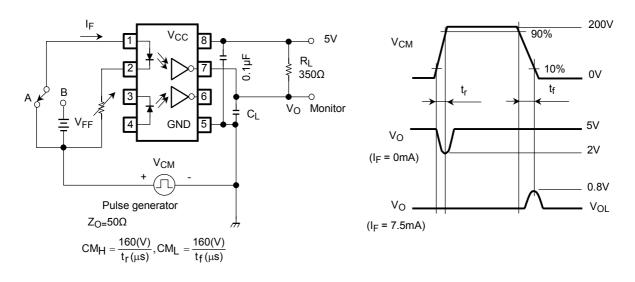
Test Circuit 1. tpHL And tpLH



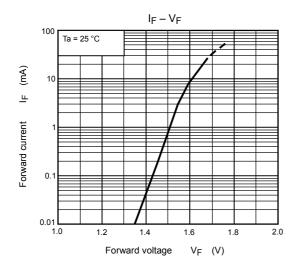


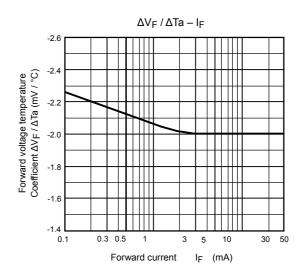
* C_L is approximately 15pF which includes probe and stray wirng capacitance.

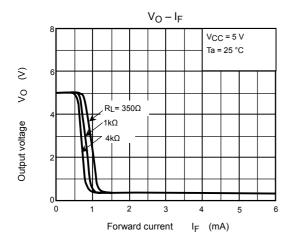
Test Circuit 2. Transient Immunity And Typical Waveforms.

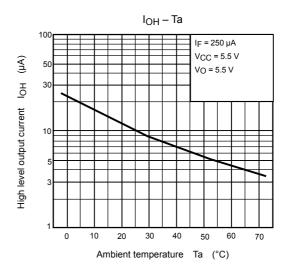


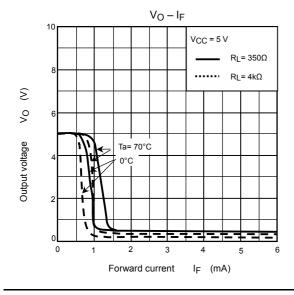
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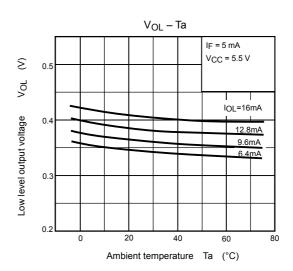


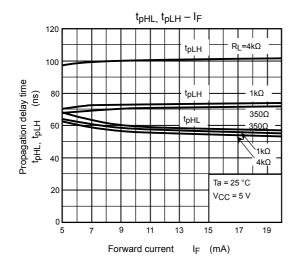


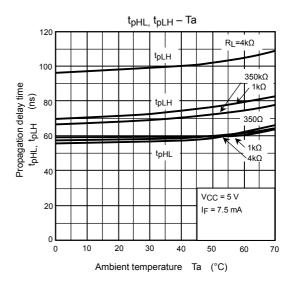


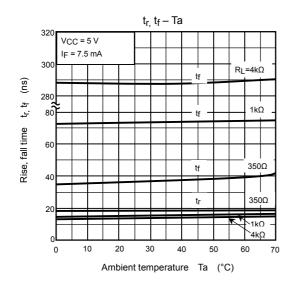












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